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|-----------------------------------|--|-------------------------|---|--------------------------------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination 10/657,652 SKINNER ET AL. | |
| | | Examiner | Art Unit | Page 1 of 1 Theresa Trieu 3748 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-4,560,329 | 12-1985 | Hirahara et al. | 418/47 |
| | B | US-4,886,435 | 12-1989 | Sawai et al. | 418/DIG.1 |
| | C | US-6,358,019 | 03-2002 | Iversen et al. | 417/312 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------------|----------------|
| | N | JP 61112795 A | 05-1986 | Japan | SHIIBAYASHI et al. | F04C 29/02 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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